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(12) **United States Design Patent** (10) **Patent No.:** **US D864,410 S**
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(54) **DISPLAY DEVICE FOR A MEASURING APPARATUS**

(71) Applicants: **ARKRAY, Inc.**, Kyoto (JP); **Alfresa Pharma Corporation**, Osaka (JP)

(72) Inventor: **Gisuke Ota**, Ichihara (JP)

(73) Assignees: **ARKRAY, Inc.**, Kyoto (JP); **Alfresa Pharma Corporation**, Osaka (JP)

(**) Term: **15 Years**

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(30) **Foreign Application Priority Data**

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(52) **U.S. Cl.**
USPC **D24/216**

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CPC G01N 33/025; G01N 33/50; G01N 2035/00306; G01N 2035/00326; G01N 2035/00336; G01N 33/00336; G01N 33/53; G01N 33/5302; G01N 33/569
See application file for complete search history.

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Primary Examiner — Garth Rademaker

Assistant Examiner — Fritzgerald L Butac

(74) *Attorney, Agent, or Firm* — Stuebaker & Brackett
PC

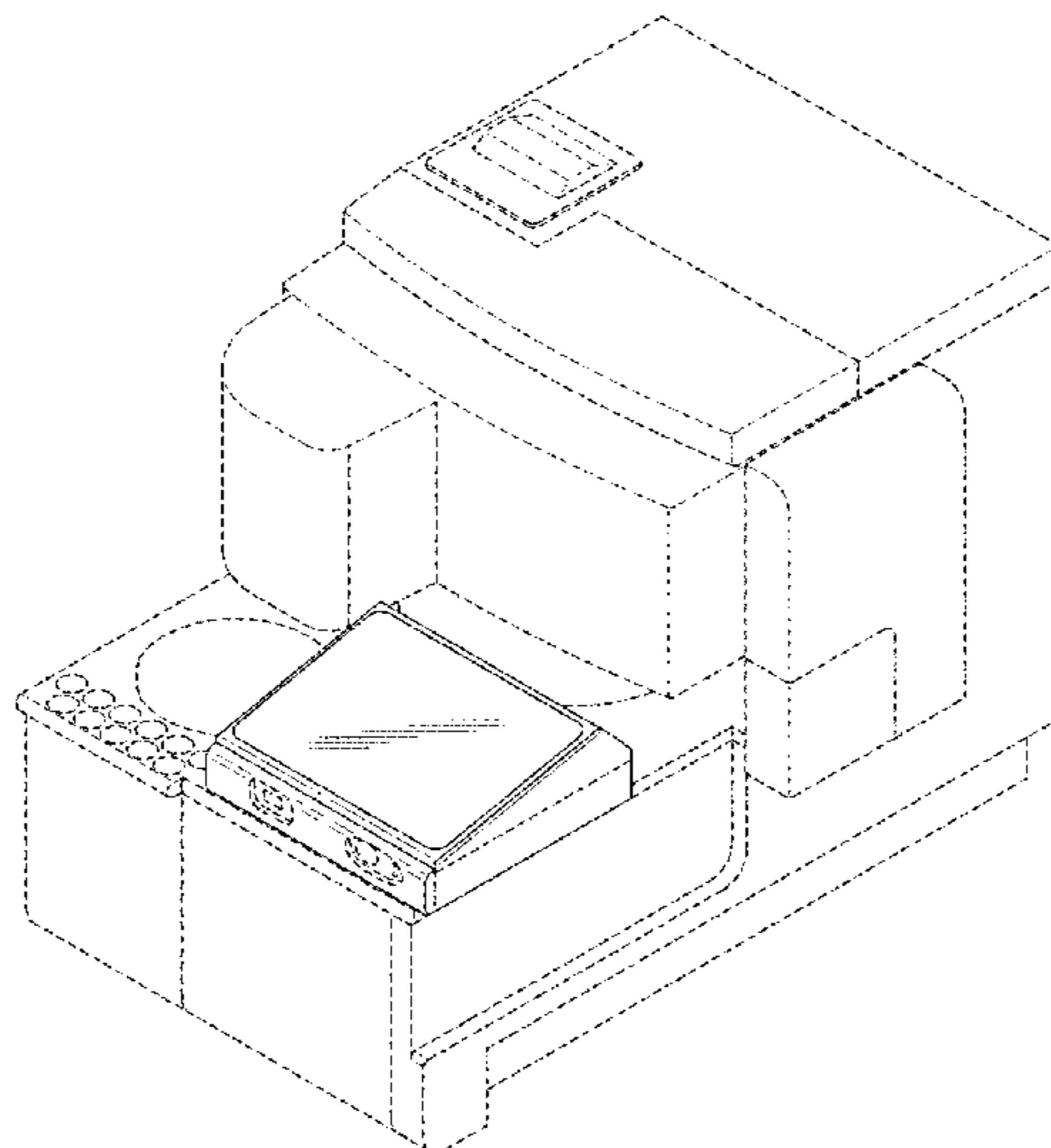
(57) **CLAIM**

I claim the ornamental design for a display device for a measuring apparatus, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of a display device for a measuring apparatus according to my design;
FIG. 2 is a front elevational view of the same display device for a measuring apparatus;
FIG. 3 is a rear elevational view of the same display device for a measuring apparatus;
FIG. 4 is a top plan view of the same display device for a measuring apparatus;
FIG. 5 is a bottom view of the same display device for a measuring apparatus;
FIG. 6 is a left side elevational view of the same display device for a measuring apparatus;
FIG. 7 is a right side elevational view of the same display device for a measuring apparatus; and,
FIG. 8 is a perspective view similar to FIG. 1, wherein the display device for a measuring apparatus is rearranged in a different orientation than that shown in FIG. 1.
The broken lines show the body of a measuring apparatus and portions of a display device for a measuring apparatus, none of which form a part of the claimed design.

1 Claim, 6 Drawing Sheets



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Fig. 1

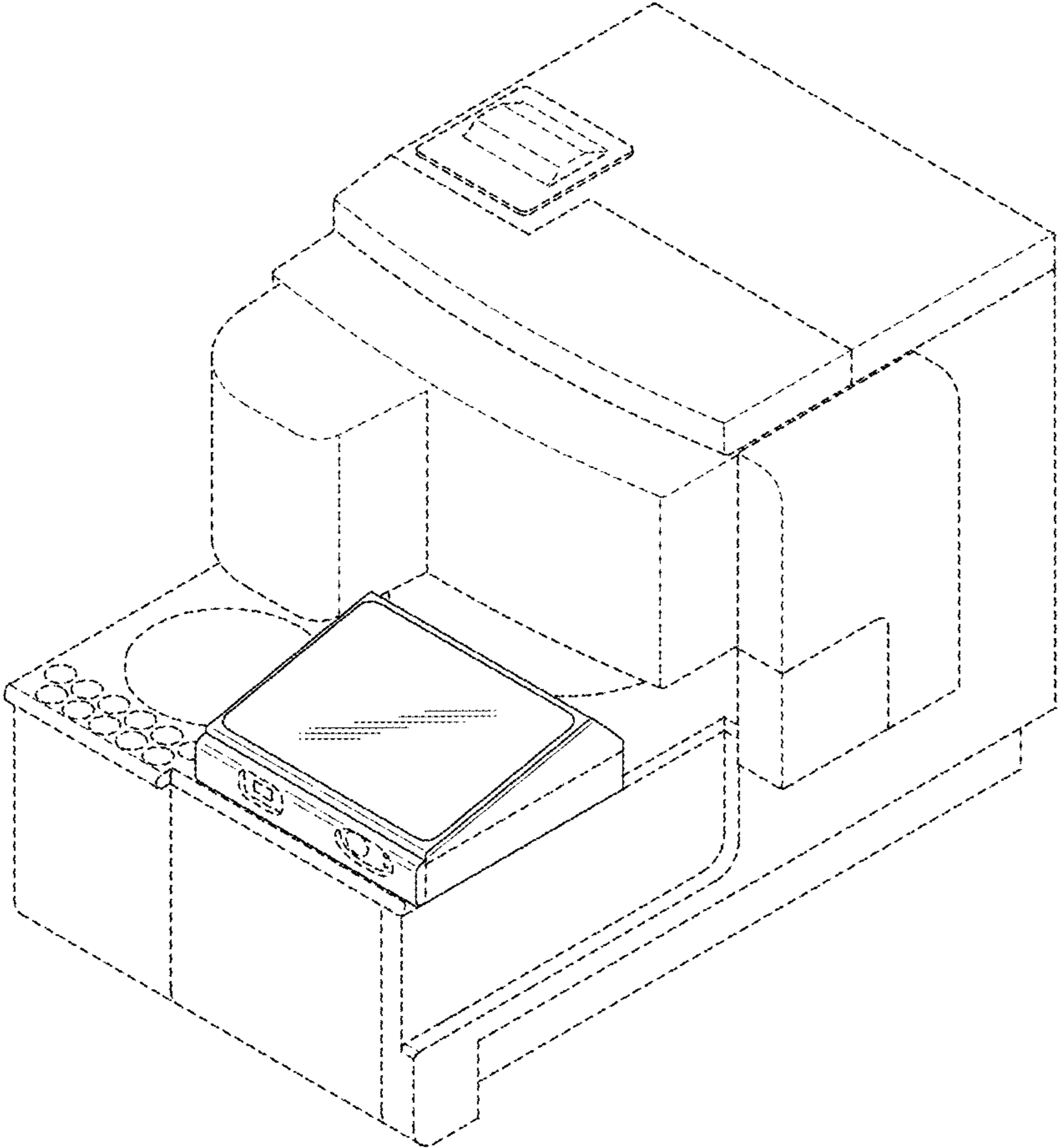


Fig. 2

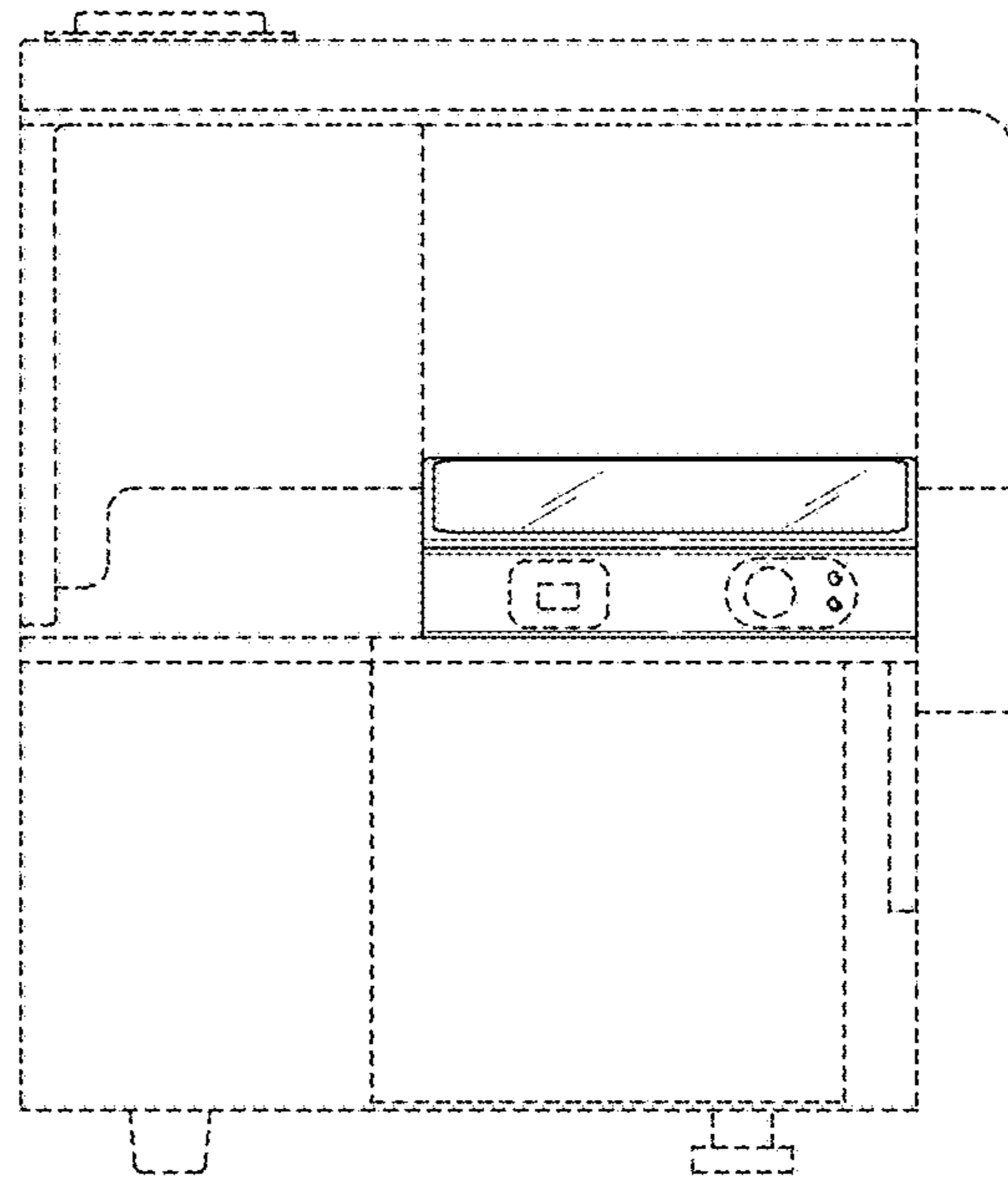


Fig. 3

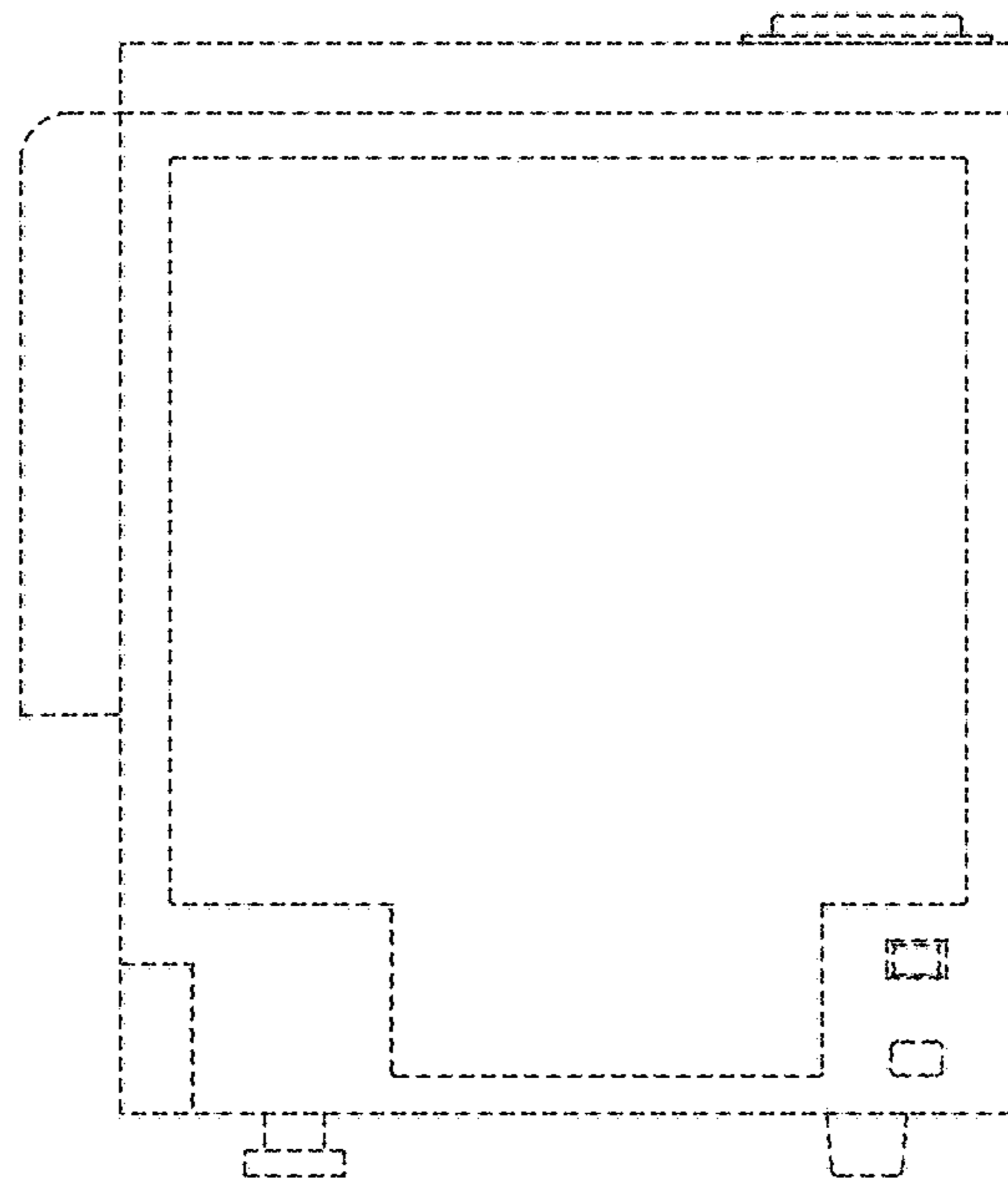


Fig. 4

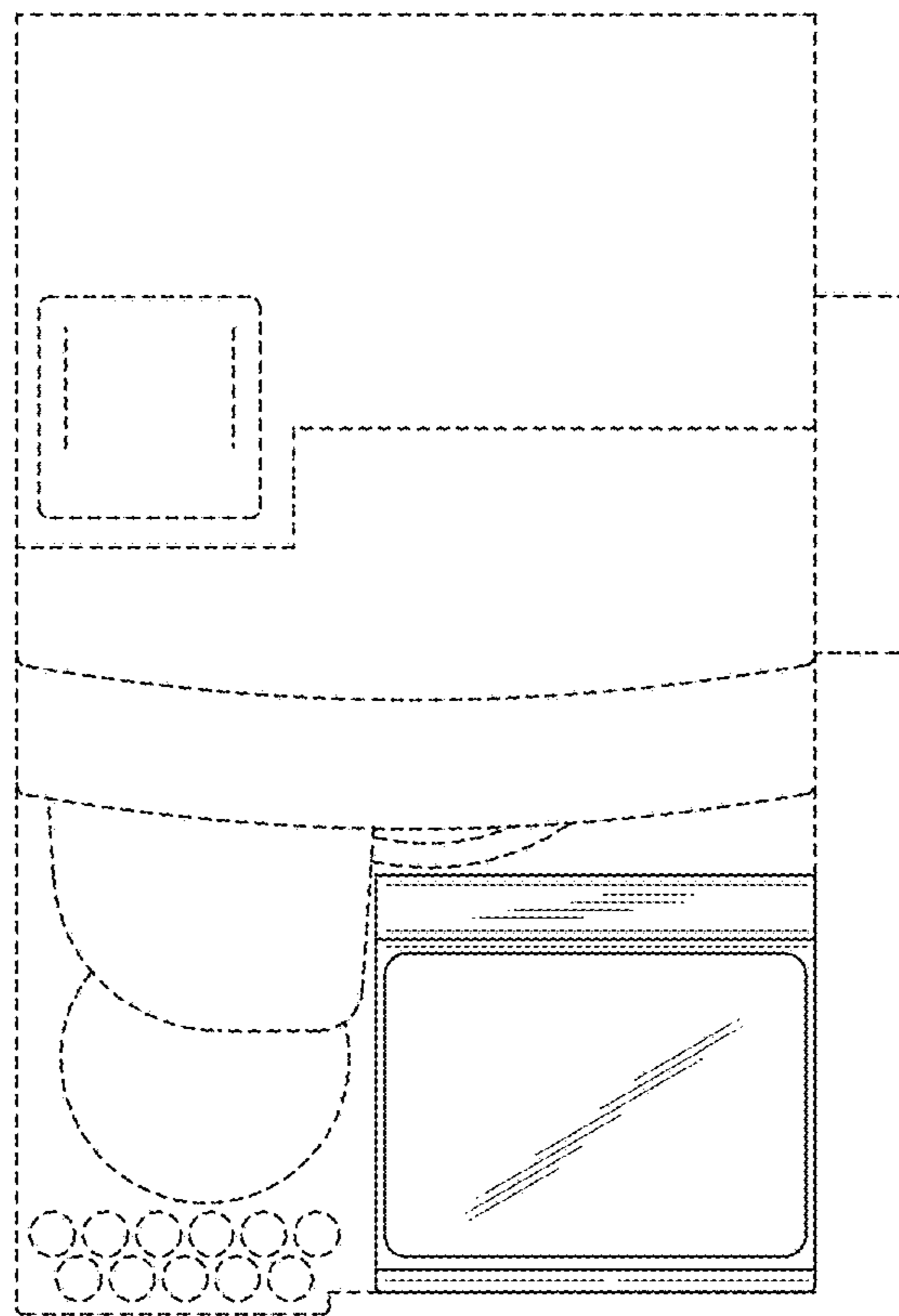


Fig. 5

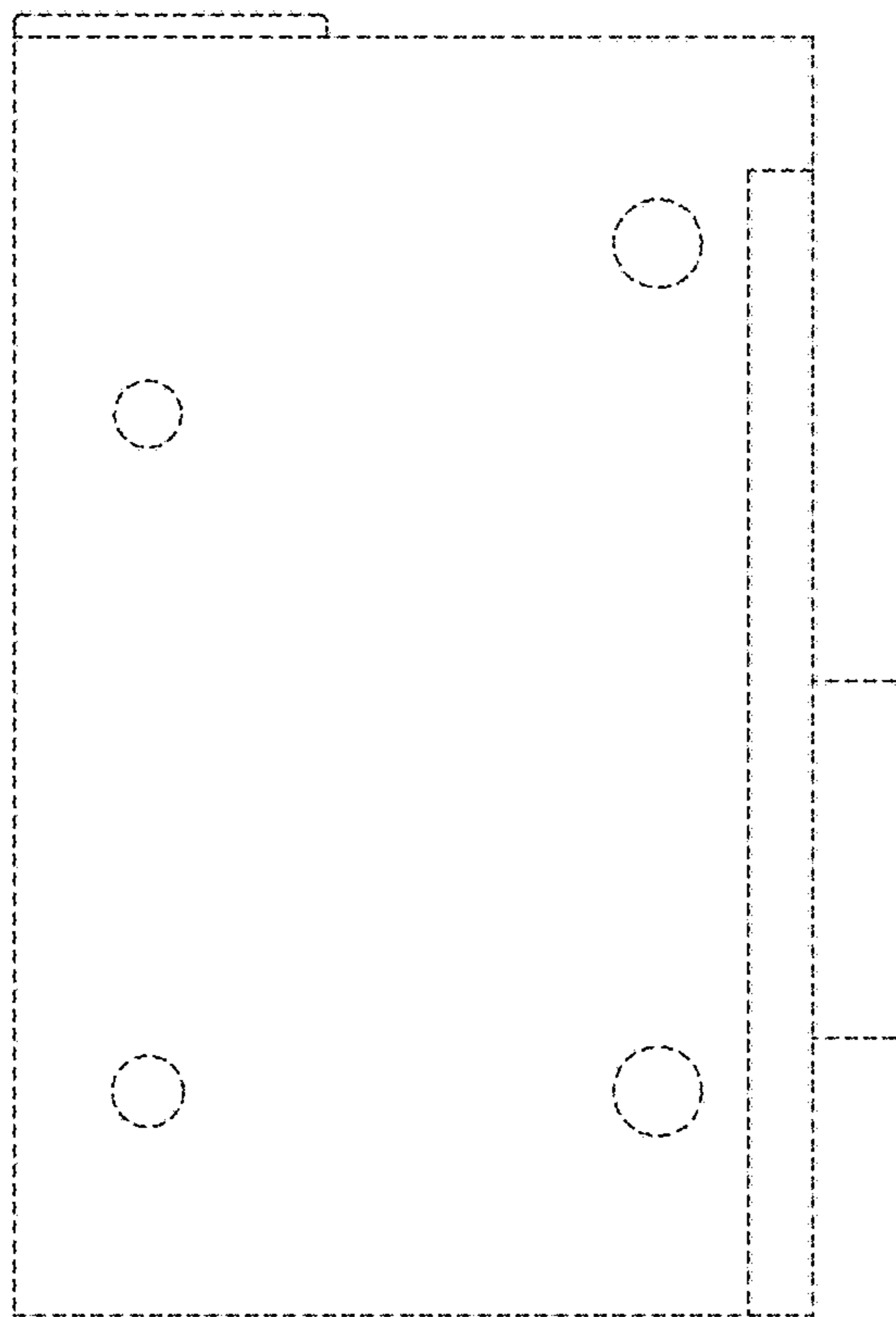


Fig. 6

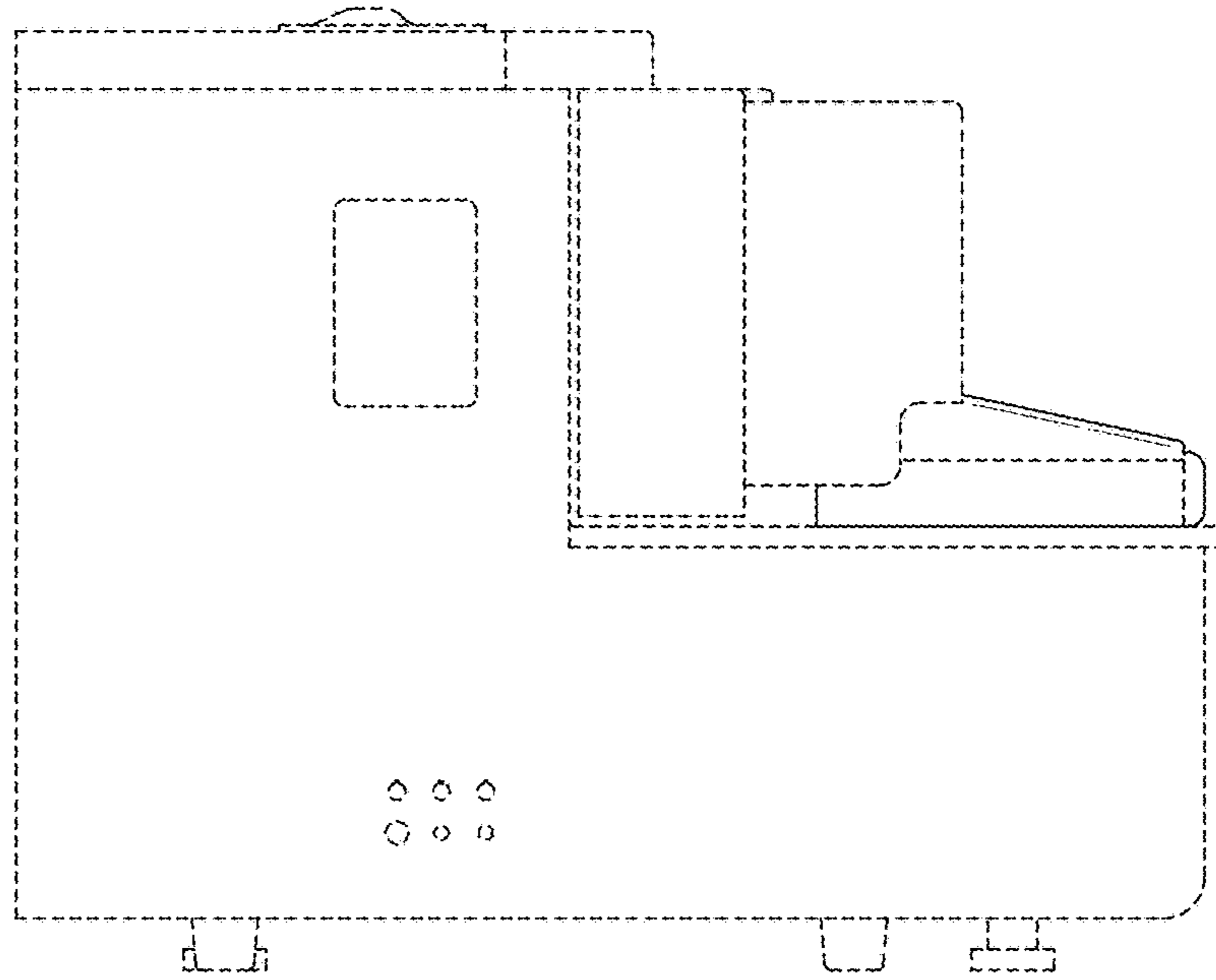


Fig. 7

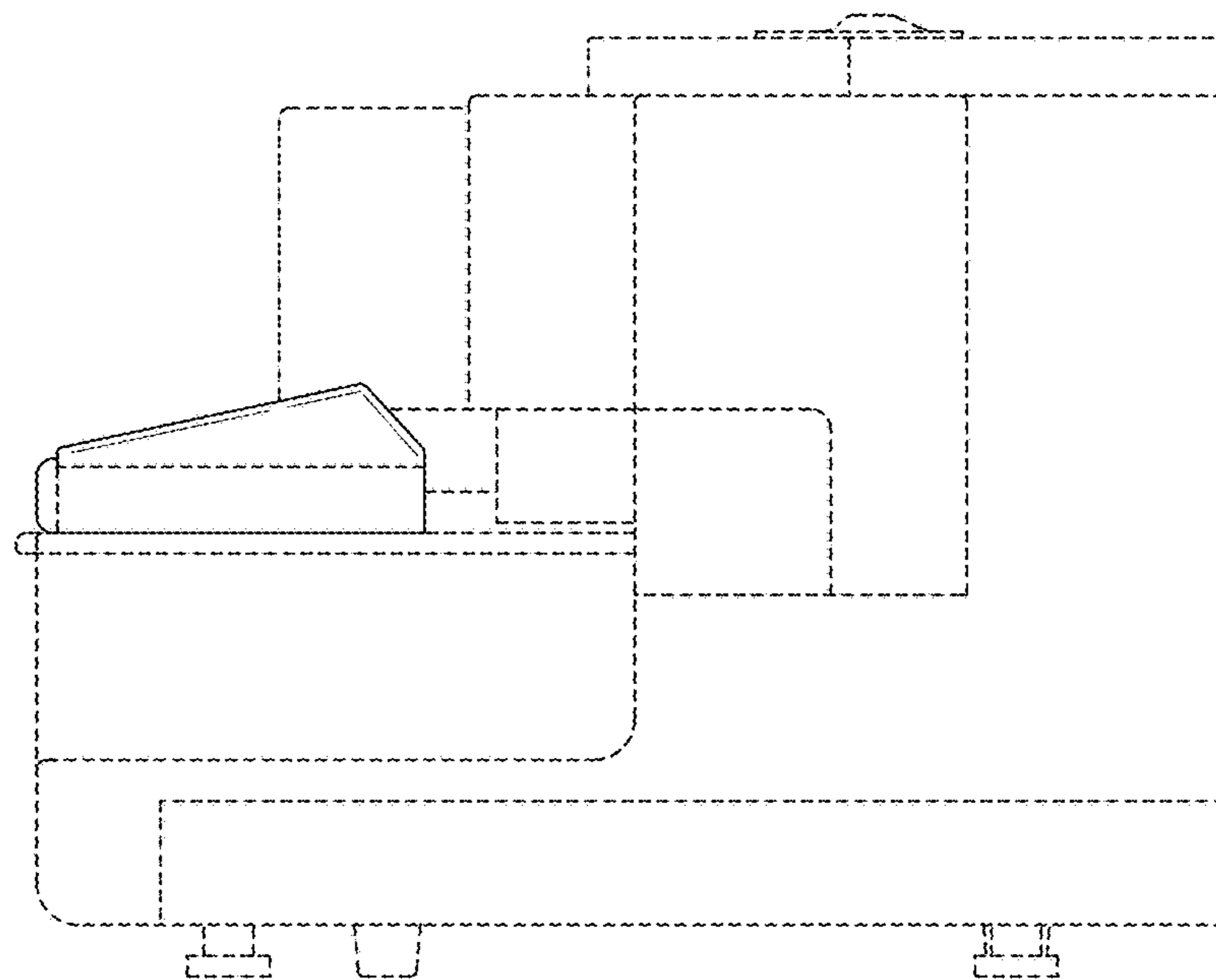


Fig. 8

